

June 2014

# **FDP053N08B**

# N-Channel PowerTrench<sup>®</sup> MOSFET 80 V, 120 A, 5.3 m $\Omega$

### **Features**

- $R_{DS(on)}$  = 4.2 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 75 A
- Low FOM  $R_{DS(on)} * Q_G$
- Low Reverse-Recovery Charge, Q<sub>rr</sub> = 62.5 nC
- · Soft Reverse-Recovery Body Diode
- Enables High Efficiency in Synchronous Rectification
- · Fast Switching Speed
- · 100% UIL Tested
- · RoHS Compliant

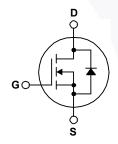
# Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

### **Applications**

- · Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- · Motor Drives and Uninterruptible Power Supplies





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol		Parameter		FDP053N08B	Unit
$V_{DSS}$	Drain to Source Voltage			80	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
		- Continuous (T <sub>C</sub> = 25	5°C, Silicon Limited)	120*	
I <sub>D</sub> Drain Current		- Continuous (T <sub>C</sub> = 10	00°C, Silicon Limited)	85.2*	Α
		- Continuous (T <sub>C</sub> = 25	5°C, Package Limited)	75	/
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	480	Α
E <sub>AS</sub>	Single Pulsed Avalanch	e Energy	(Note 2)	365	mJ
dv/dt	Peak Diode Recovery d	v/dt	(Note 3)	6.0	V/ns
D	Dower Dissinction	$(T_C = 25^{\circ}C)$		146	W
$P_{D}$	Power Dissipation	- Derate Above 25°C		0.97	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage	Temperature Range		-55 to +175	°C
T <sub>L</sub>	Maximum Lead Temper	ature for Soldering, 1/8" from Ca	se for 5 Seconds	300	°C

<sup>\*</sup> Package limitation current is 75A.

#### **Thermal Characteristics**

Symbol	Parameter FDP053N08B			
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 1.03			
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5			

# **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDP053N08B_F102	FDP053N08B	TO-220	Tube	N/A	N/A	50 units

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	80	-	-	V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C	-	0.089	-	V/°C
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 64 \text{ V}, T_{C} = 150^{\circ}\text{C}$	-	-	500	μА
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	-	±100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	-	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 75 A	-	4.2	5.3	mΩ
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 75 A	-	100	-	S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 40 V V 0 V	-	4480	5960	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1  MHz	-	740	985	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 1/11/12	-	20.5	-	pF
C <sub>oss(er)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	- \	1333	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		- \	65.4	85	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 40 \text{ V}, I_{D} = 75 \text{ A},$	-	26.7	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10 V	-	15.3	-	nC
V <sub>plateau</sub>	Gate Plateau Volatge	(Note 4	-	6.0	-	V
Q <sub>sync</sub>	Total Gate Charge Sync.	V <sub>DS</sub> = 0 V, I <sub>D</sub> = 37.5 A	-	52.4	-	nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	-	64.2	-	nC
ESR	Equivalent Series Resistance (G-S)	f = 1 MHz	-	1.2	-	Ω

## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	32	74	ns
t <sub>r</sub>		$V_{DD} = 40 \text{ V}, I_D = 75 \text{ A},$	-/ -	30	70	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$	-	44	98	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	16	42	ns

### **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current				120*	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	480	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 75 A	-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 40 V, I <sub>SD</sub> = 75 A,	- ,	59.3	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	62.5	-	nC

#### Notes

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 3 mH,  $I_{AS}$  = 15.6 A, starting  $T_J$  = 25°C.
- 3. I  $_{SD} \leq$  100 A, di/dt  $\leq$  200 A/ $\mu s,~V_{DD} \leq$  BV  $_{DSS},$  starting T  $_{J}$  = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

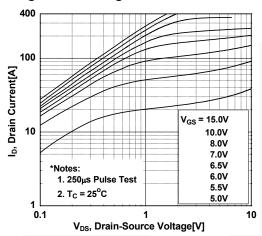


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

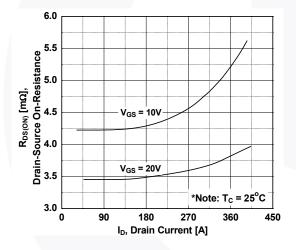


Figure 5. Capacitance Characteristics

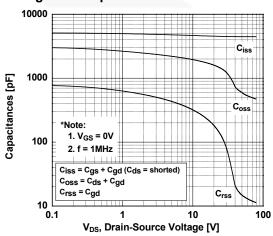


Figure 2. Transfer Characteristics

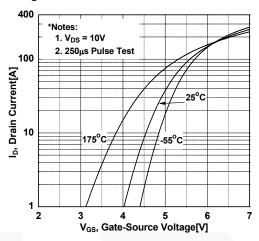


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

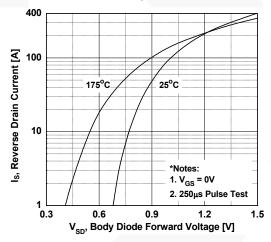
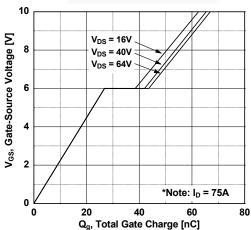


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

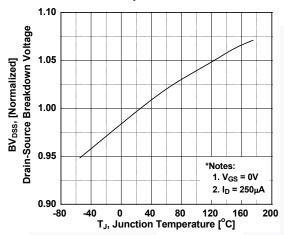


Figure 9. Maximum Safe Operating Area

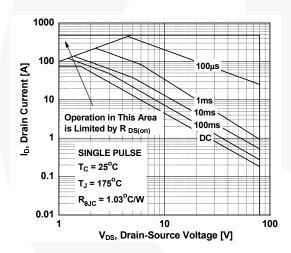


Figure 11. Eoss vs. Drain to Source Voltage

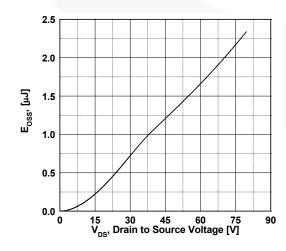


Figure 8. On-Resistance Variation vs. Temperature

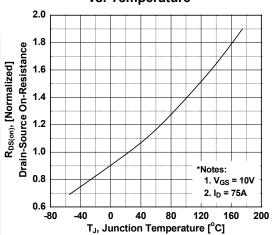


Figure 10. Maximum Drain Current vs. Case Temperature

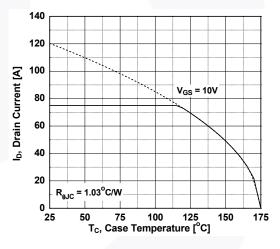
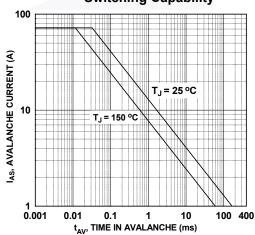
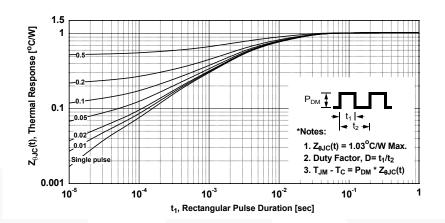


Figure 12. Unclamped Inductive Switching Capability



# **Typical Performance Characteristics** (Continued)





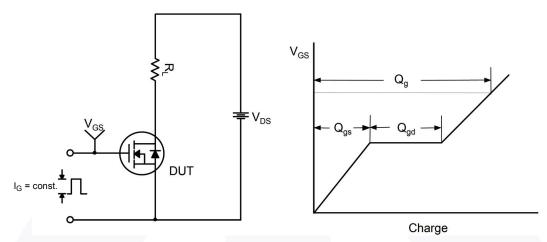


Figure 14. Gate Charge Test Circuit & Waveform

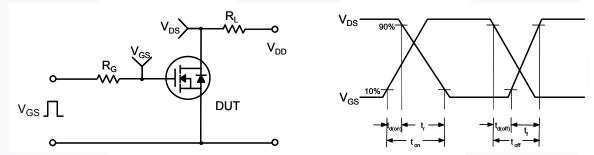


Figure 15. Resistive Switching Test Circuit & Waveforms

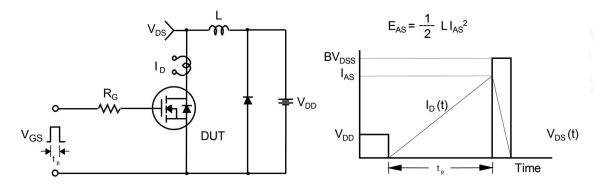


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

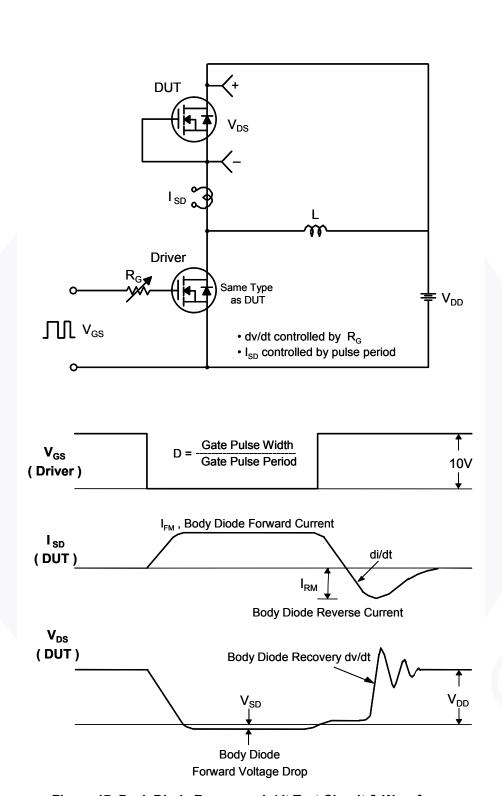


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

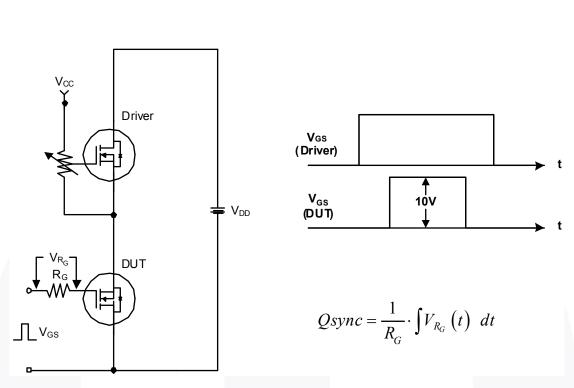


Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms

### **Mechanical Dimensions**

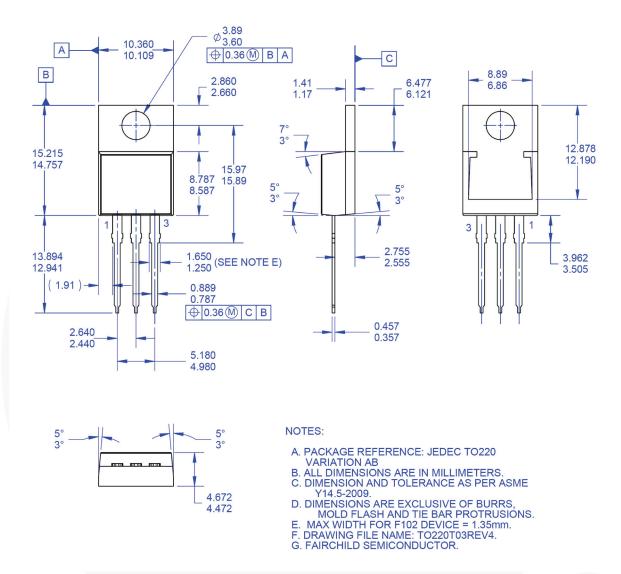


Figure 19. TO-220, Molded, 3-Lead, Jedec Variation AB

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